


FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date submitted to PTO: March 29, 2004				ATTORNEY DOCKET NO. 03500.017666		APPLICATION NO. 10/693,914	
				APPLICANT TAKAHARU KONDO, ET AL.			
				FILING DATE October 28, 2003		GROUP Not Yet Assigned	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/JB/		5,684,325	11/04/1997	Kataoka et al.	257	433	
		6,307,145 B1	10/23/2001	Kataoka et al.	136	251	
		5,981,934	11/09/1999	Higashikawa	250	214	
		5,973,258	10/26/1999	Shiotsuka et al.	136	252	
		6,034,323	03/07/2000	Yamada et al.	136	259	
		6,133,522	10/17/2000	Kataoka et al.	136	259	
		6,316,832 B1	11/13/2001	Tsuzuki et al.	257	747	
		6,133,061	10/17/2000	Sonoda	438	69	
		6,488,995 B1	12/03/2002	Nishimoto et al.	427	574	
		6,252,158 B1	06/26/2001	Higashikawa	136	258	
		6,162,986	12/19/2000	Shiotsuka et al.	136	244	
/JB/		6,544,877 B1	04/08/2003	Sonoda et al.	438	609	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
/JB/		2002-167695	06/11/2002	Japan			Abstract
/JB/		10-140373	05/26/1998	Japan			Abstract
/JB/		3273294	08/27/1996	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED			
/Jeffrey Barton/				08/20/2007			

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U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/JB/		6,414,236 B1	07/02/2002	Kataoka et al.	136	251	
		6,515,216 B2	02/04/2003	Zenko et al.	136	244	
		6,576,112 B2	06/10/2003	Sonoda et al.	205	155	
		6,653,165 B2	11/25/2003	Kondo et al.	438	73	
		5,486,238	01/23/1996	Nakagawa et al.	136	259	
		5,770,463	06/23/1998	Nakagawa et al.	437	2	
		5,660,646	08/26/1997	Kataoka et al.	136	251	
		6,172,296 B1	01/09/2001	Iwasaki et al.	136	256	
		6,113,718	09/05/2000	Yamada et al.	156	78	
		5,578,141	11/26/1996	Mori et al.	136	251	
		5,718,772	02/17/1998	Mori et al.	136	251	
		6,320,115 B1	11/20/2001	Kataoka et al.	136	251	
/JB/		5,800,631	09/01/1998	Yamada et al.	136	251	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
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				APPLICANT TAKAHARU KONDO, ET AL.			
				FILING DATE October 28, 2003		GROUP Not Yet Assigned	

U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
/JB/	6,175,075 B1	01/16/2001	Shiotsuka et al.	136	251		
	6,472,248 B2	10/29/2002	Shiozaki et al.	438	97		
	6,544,877 B1	04/08/2003	Sonoda et al.	438	609		
	6,576,112 B2	06/10/2003	Sonoda et al.	205	155		
	6,660,931	12/09/2003	Toyama et al.	136	256		
	6,664,597	12/16/2003	Takeyama et al.	257	347		
	6,693,237	02/17/2004	Zenko et al.	136	251		
	5,804,466	09/08/1998	Arao et al.	438	95		
	2003/0104664 A1	06/05/2003	Kondo et al.	438	200		
	2003/0075717 A1	04/24/2003	Kondo et al.	257	64		
	2002/0166581 A1	11/14/2002	Kondo et al.	136	258		
	2003/0153165 A1	08/14/2003	Kondo et al.	438	478		
/JB/	2002/0117661 A1	08/29/2002	Kondo et al.	257	21		

FOREIGN PATENT DOCUMENTS							
DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT		

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)		

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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date submitted to PTO: May 14, 2004		ATTY DOCKET NO. 03500.017666		APPLICATION NO. 10/693,914	
		APPLICANT TAKAHARU KONDO, ET AL.			
		FILING DATE October 28, 2003		GROUP Unassigned	

U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<div style="border: 1px solid black; border-radius: 50%; padding: 5px; display: inline-block;"> OIPE JIB/ MAY 14 2004 PATENT AND TRADEMARK OFFICE </div>	2003-0085129 A1	05/08/2003	Shishido	205	155	

FOREIGN PATENT DOCUMENTS						
DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)	
/JB/	Inoue et al., "Optical confinement effect in a-SiGe solar cells on stainless steel substrates", Extended Abstracts, Japan Society of Appl. Phys., 1990, p. 747.
/JB/	Sannomiya et al., "a-SiC/a-Si/a-SiGe Multi-Bandgap Stacked Solar Cells with Bandgap Profiling", Tech. Dig. Int. PVSEC-5, Kyoto, Japan, 1990, pp. 387-390.

EXAMINER	/Jeffrey Barton/	DATE CONSIDERED	08/20/2007
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